

[Electronic Supplementary Information]

Perpendicular Orientation of Microdomains in PS-*b*-PMMA Thin Films on the PS brushed Substrates

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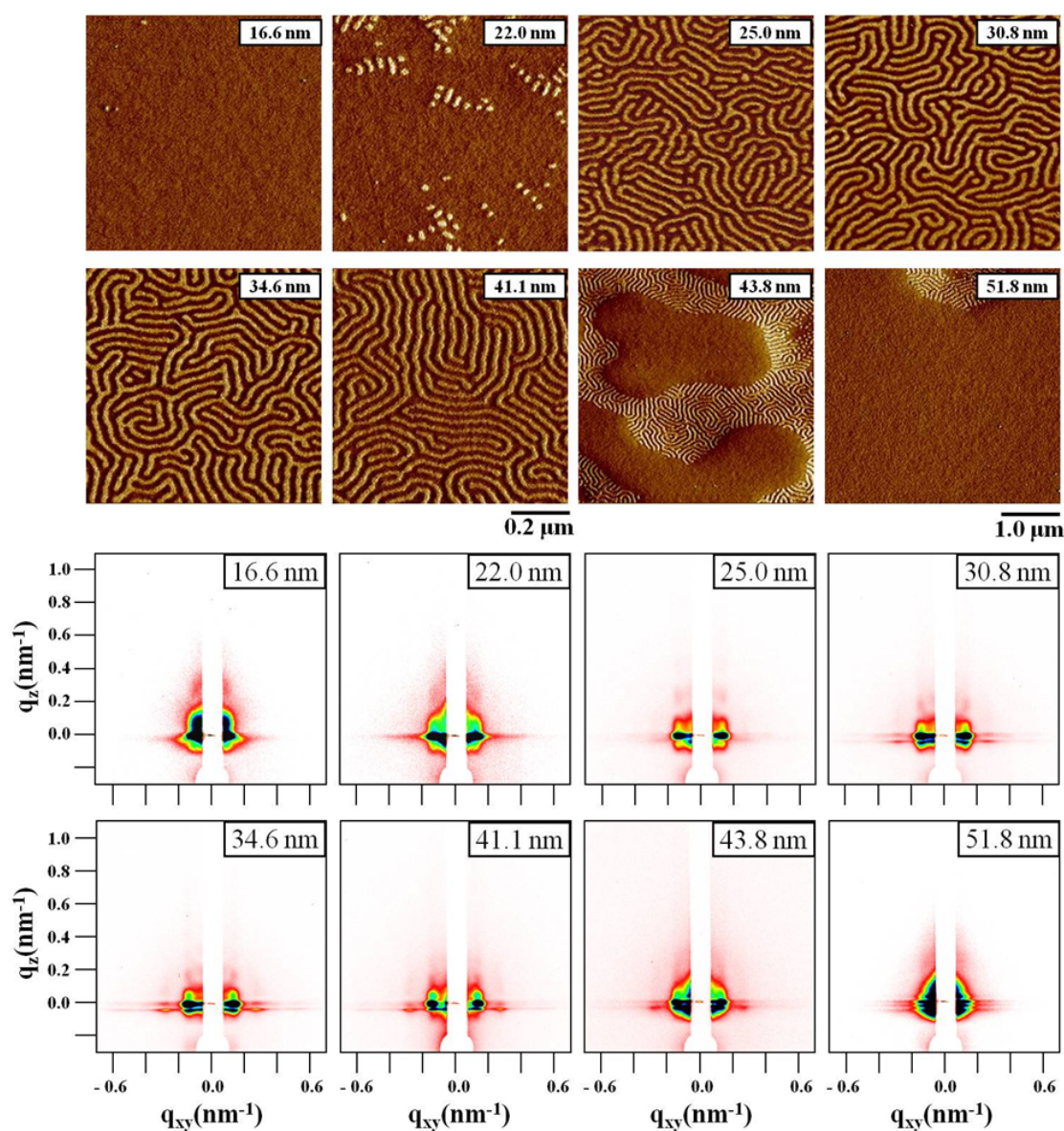


Figure S1. The SFM phase images for lamellar morphology on a PS brushed substrate with $\sigma = 0.116$ chains/nm², and the corresponding 2D-GISAXS patterns at an incidence angle (α_i) of 0.190 °, where the film thickness of lamella-forming PS-*b*-PMMA were varied. All the film samples were annealed at 180 °C under vacuum for 24 h to obtain an equilibrium morphology.